

# **Device Modeling Report**

COMPONENTS:THYRISTOR  
PART NUMBER:MCR218-8FP  
MANUFACTURER: MOTOROLA SEMICONDUCTOR



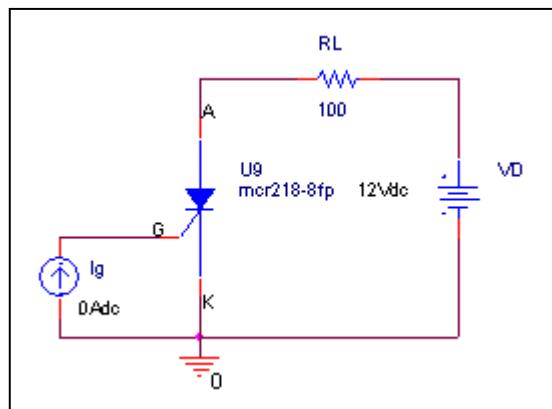
**Bee Technologies Inc.**

## DIODE MODEL

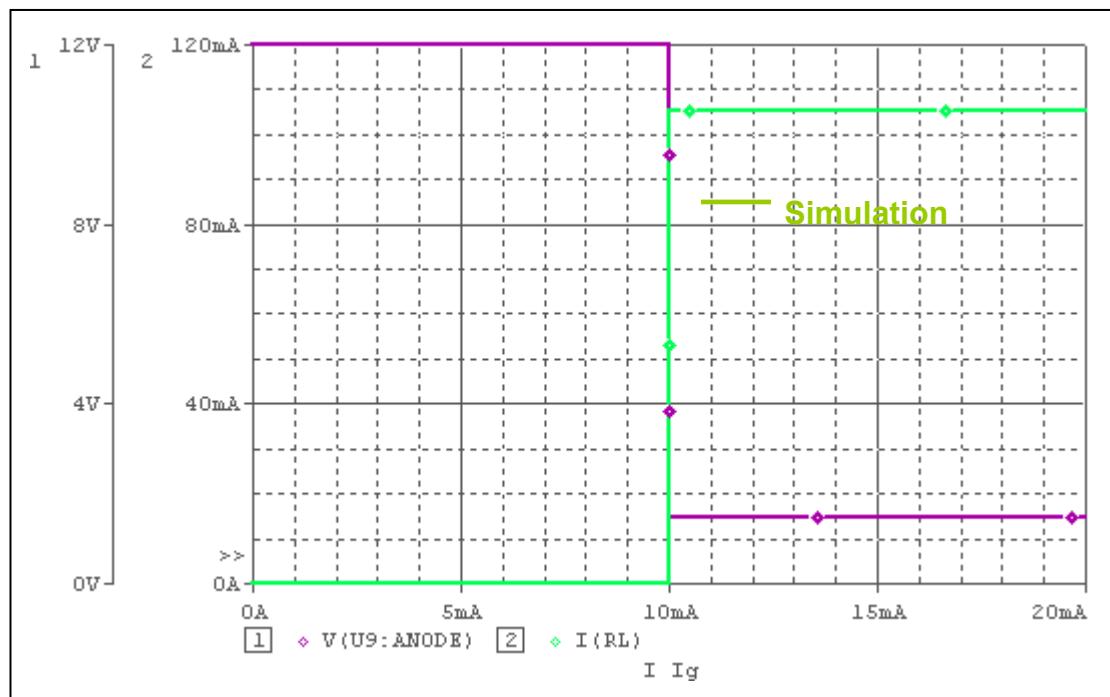
Pspice model Parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time

## IG-VT Characteristic

Evaluation Circuit



Simulation result

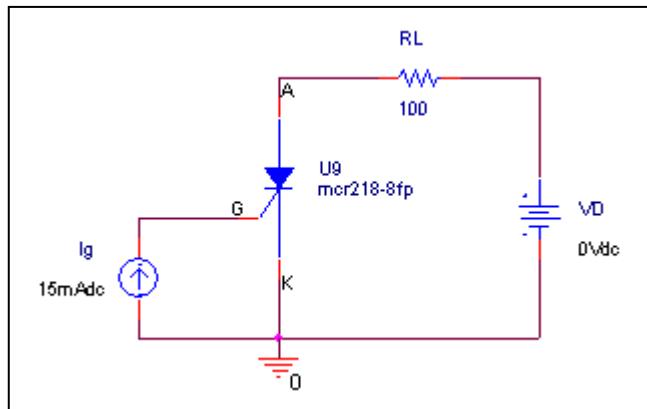


Comparison Table

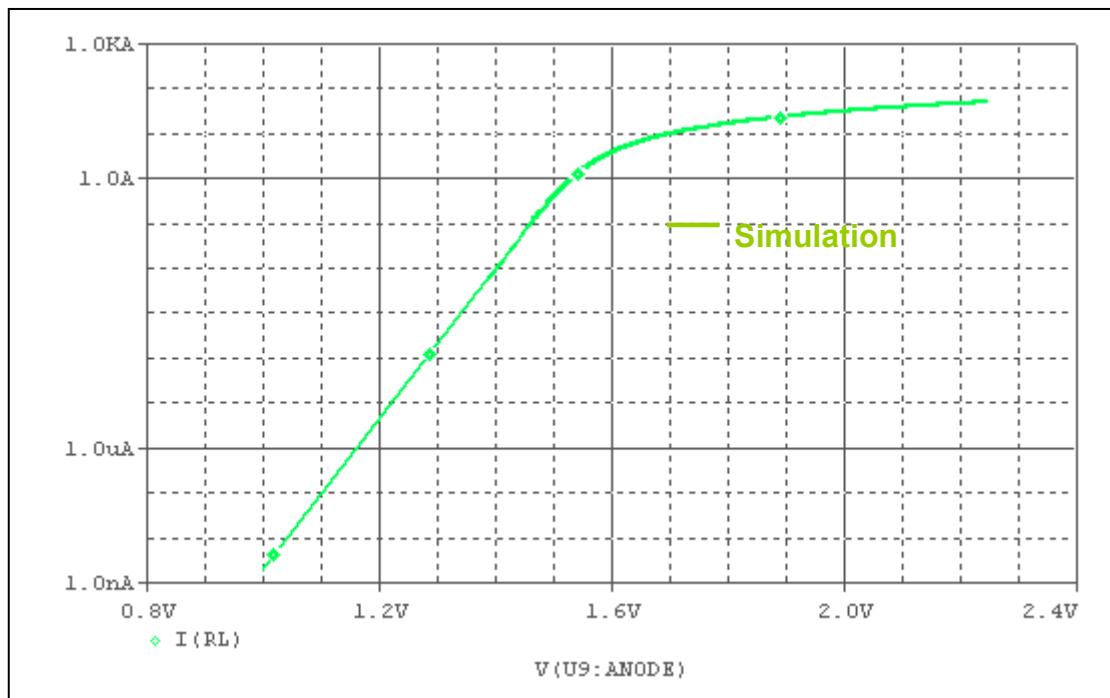
	Measurement	Simulation	% Error
$I_{G_T}$ (mA)	10	10.005	0.05000
$V_{G_T}$ (V)	1.5(max)	1.4624	-2.50667

## ITM-VM Characteristic

Evaluation Circuit



Simulation result

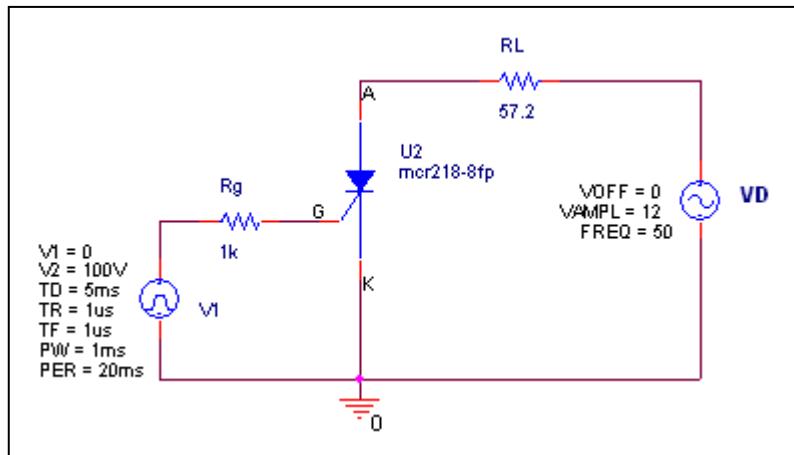


Comparison Table

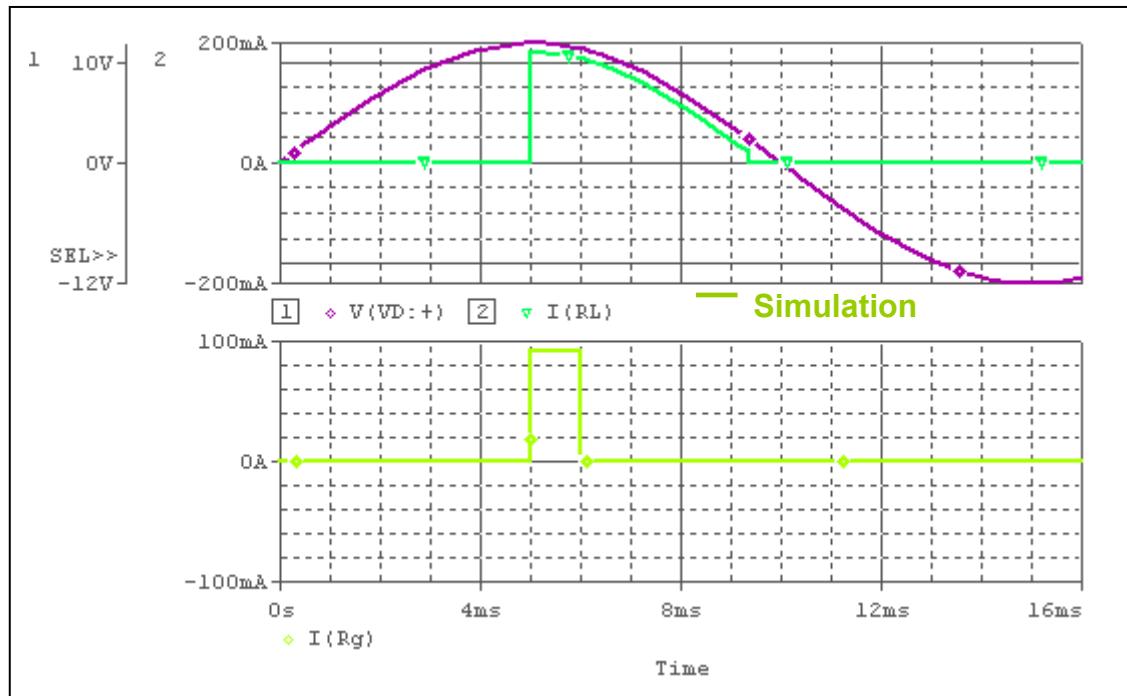
At ITM=16A	Measurement	Simulation	% Error
VTM(V)	1.8(max)	1.7911	-0.49444

## Holding Characteristic (IH)

Evaluation Circuit



Simulation result

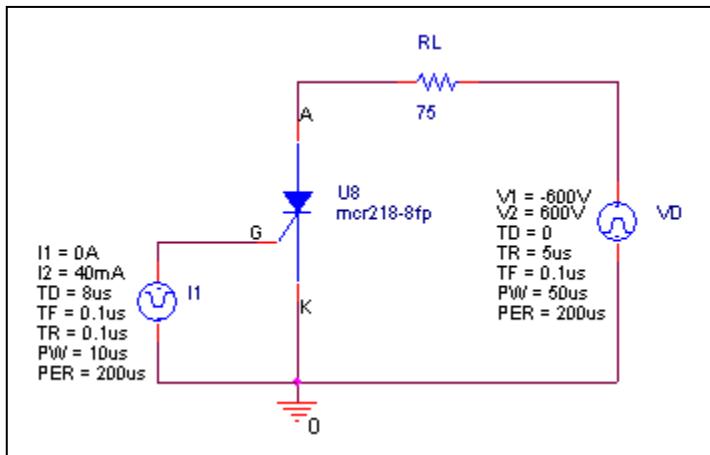


Comparison Table

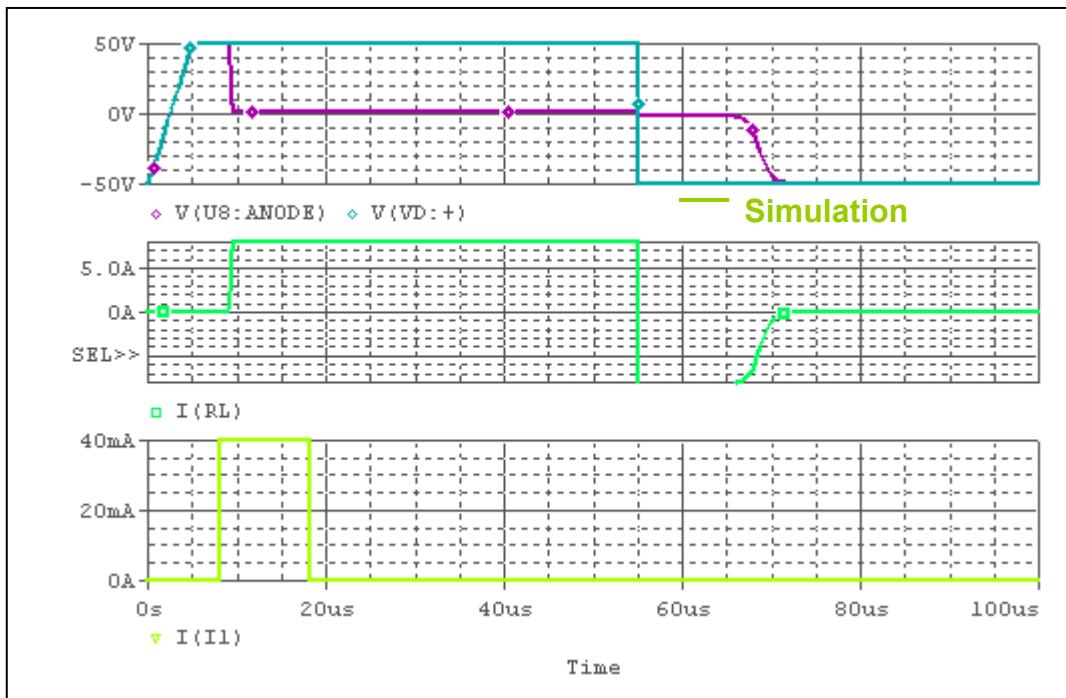
<b>VD=12V</b>	<b>Measurement</b>	<b>Simulation</b>	<b>% Error</b>
<b>IH(mA)</b>	<b>16</b>	<b>16.083</b>	<b>0.51875</b>

## Switching Time Characteristic

Evaluation Circuit



Simulation result



Comparison Table

	Measurement	Simulation	%Error
T <sub>on</sub> (us)	1.5	1.5182	1.21333
T <sub>off</sub> (us)	15	15.014	0.09333